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U.S. Department of Commerce Patent and Trademark Office

Attorney's Docket No. 09712-213002

Application No.

Information Disclosure Statement by Applicant (Use several sheets if necessary)

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Peter J. de Groot et al.

Filing Date

Group Art Unit

(37 CFR §1.98(b))

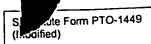
March 22, 2004

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Attorney's Docket No. 09712-213001

Application No. 10/190,353

Information Disclosure Statement by Applicant (Use several sheets if necessary)

Applicant Peter de Groot et al.

Filing Date July 3, 2002 Group Art Unit 2877

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U.S. Department of Commerce Patent and Trademark Office Attorney's Docket No. 09712-213001

Application No. 10/190,353

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Peter de Groot et al.

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July 3, 2002

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Peter de Groot et al.

Filing Date July 3, 2002

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Group Art Unit 2877

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